

**Search Notes**

Application/Control No.

10/041,005

Examiner

Shin-Hon Chen

Applicant(s)/Patent under  
Reexamination

HALASZ ET AL.

Art Unit

2131

**SEARCHED**

Class	Subclass	Date	Examiner
713	168,171, 181,183	9/25/2006	S.C.
726	2-4, 12	9/25/2006	S.C.
726	21	9/25/2006	S.C.
709	219,223	9/11/2007	S.C.
709	225,229	9/11/2007	S.C.
379	88.17	9/11/2007	S.C.
455	411,414.1	9/11/2007	S.C.

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
726	2-4, 12	9/11/2007	S.C.
726	21	9/11/2007	S.C.
713	154,155	9/11/2007	S.C.
713/168; 709/219,223,225,229; 379/88.17; 455/411,414.1		9/11/2007	S.C.

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search- see search history)	9/11/2007	S.C.